

## AMENDMENTS TO THE SPECIFICATION

Please amend the paragraphs beginning at line 5 on page 1 of the specification as follows:

This Application is related to U.S. Patent Application Serial Number 10/791,459 [[\_\_\_\_\_]] by E. Sheng et al., filed on March 1, 2004 [[\_\_\_\_\_]], entitled "System and Method for Controlling Temperature During Burn-In," with Attorney Docket No. TRAN-P282, assigned to the assignee of the present invention, and hereby incorporated by reference in its entirety.

This Application is related to U.S. Patent Application Serial Number 10/791,099 [[\_\_\_\_\_]] by E. Sheng et al., filed on March 1, 2004 [[\_\_\_\_\_]], entitled "System and Method for Reducing Temperature Variation During Burn-In," with Attorney Docket No. TRAN-P283, assigned to the assignee of the present invention, and hereby incorporated by reference in its entirety.

Please amend the paragraph (the abstract) starting at line 5 on page 18 of the specification as indicated on the next page:

Systems and methods for reducing temperature dissipation during burn-in testing are described. A plurality of devices under test are each subject to a body bias voltage. The body bias voltage ~~reduces~~ is selected to substantially minimize leakage current associated with the plurality of devices under test. Accordingly, heat dissipation is reduced during burn-in.